

AOT66620L/AOB66620L

60V N-Channel AlphaSGT™

General Description

- Trench Power MOSFET technology
- Low R_{DS(ON)}
- Excellent Gate Charge x R_{DS(ON)} Product(FOM)
- RoHS and Halogen-Free Compliant

Product Summary

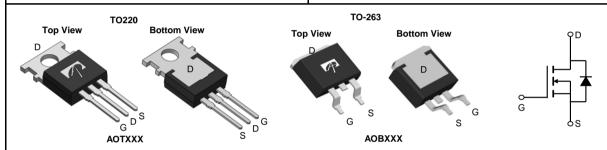
 $\begin{array}{ll} V_{DS} & 60V \\ I_{D} \; (at \; V_{GS} \! = \! 10V) & 57A \\ R_{DS(ON)} \; (at \; V_{GS} \! = \! 10V) & < 8.5 m\Omega \\ R_{DS(ON)} \; (at \; V_{GS} \! = \! 8V) & < 11 m\Omega \end{array}$

100% UIS Tested 100% Rg Tested



Applications

- Synchronous Rectification in SMPS
- ATX and Gaming Power Supplies
- Switching Applications



Orderable Part Number	Package Type	Form	Minimum Order Quantity		
AOT66620L	TO-220	Tube	1000		
AOB66620L	TO-263	Tape & Reel	800		

Absolute Maximum Ratings T_A=25°C unless otherwise noted

Parameter		Symbol	Maximum	Units	
Drain-Source Voltage		V_{DS}	60	V	
Gate-Source Voltage		V_{GS}	±20	V	
Continuous Drain	T _C =25°C		57		
Current	T _C =100°C	'D	36	A	
Pulsed Drain Current ^C		I _{DM}	126		
Continuous Drain Current	T _A =25°C		23	^	
	T _A =70°C	IDSM	18	A	
Avalanche Current ^C		I _{AS}	20	A	
Avalanche energy	L=0.3mH ^C	E _{AS}	60	mJ	
	T _C =25°C	В	50	W	
Power Dissipation ^B	T _C =100°C	P _D	20	VV	
	T _A =25°C	В	8.3	10/	
Power Dissipation ^A	T _A =70°C	P _{DSM}	5.3	- W	
Junction and Storage Temperature Range		T _J , T _{STG}	-55 to 150	°C	

Thermal Characteristics						
Parameter		Symbol	Тур	Max	Units	
Maximum Junction-to-Ambient A	t ≤ 10s	D	12	15	°C/W	
Maximum Junction-to-Ambient AD	Steady-State	$R_{\theta JA}$	50	60	°C/W	
Maximum Junction-to-Case	Steady-State	$R_{\theta JC}$	2	2.5	°C/W	



Electrical Characteristics (T₁=25°C unless otherwise noted)

Symbol	Parameter	Conditions		Min	Тур	Max	Units
STATIC F	PARAMETERS						
BV _{DSS}	Drain-Source Breakdown Voltage	I _D =250μA, V _{GS} =0V		60			V
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =60V, V _{GS} =0V				1	μA
1088	Zero Gate Voltage Brain Gurrent		T _J =55°C			5	μΛ
I_{GSS}	Gate-Body leakage current	V_{DS} =0V, V_{GS} =±20V				±100	nA
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}$, $I_{D}=250\mu A$		2.4	3	3.6	V
		V_{GS} =10V, I_{D} =20A			7	8.5	mΩ
$R_{DS(ON)}$	Static Drain-Source On-Resistance		T _J =125°C		11.2	13.5	
		V_{GS} =8V, I_D =20A			7.8	11	mΩ
g _{FS}	Forward Transconductance	V _{DS} =5V, I _D =20A			50		S
V_{SD}	Diode Forward Voltage	I _S =1A, V _{GS} =0V			0.7	1	V
Is	Maximum Body-Diode Continuous Current					50	Α
DYNAMIC	PARAMETERS						
C _{iss}	Input Capacitance	V _{GS} =0V, V _{DS} =30V, f=1MHz			1070		pF
Coss	Output Capacitance				310		pF
C_{rss}	Reverse Transfer Capacitance]		12		pF	
R_g	Gate resistance	f=1MHz		0.6	1.2	1.8	Ω
SWITCHI	NG PARAMETERS						
Q _g (10V)	Total Gate Charge	V _{GS} =10V, V _{DS} =30V, I _D =20A			16.0	25	nC
Q_{gs}	Gate Source Charge				5.6		nC
Q_{gd}	Gate Drain Charge				3.6		nC
Q _{oss}	Output Charge	$V_{GS}=0V$, $V_{DS}=30V$			19		nC
t _{D(on)}	Turn-On DelayTime				10		ns
t _r	Turn-On Rise Time	V_{GS} =10V, V_{DS} =30V, R_L =1.5 Ω , R_{GEN} =3 Ω			8		ns
t _{D(off)}	Turn-Off DelayTime				18		ns
t _f	Turn-Off Fall Time				5		ns
t _{rr}	Body Diode Reverse Recovery Time	I _F =20A, di/dt=500A/μs			18		ns
Q _{rr}	Body Diode Reverse Recovery Charge	I _F =20A, di/dt=500A/μs			58		nC

A. The value of R_{BJA} is measured in a still air environment with T_A =25° C. The Power dissipation P_{DSM} is based on R_{BJA} t≤ 10s and the maximum allowed junction temperature of 150° C. The value in any given application depends on the user's specific board design.

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B. The power dissipation P_D is based on T_{J(MAX)}=150° C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Single pulse width limited by junction temperature $T_{J(MAX)}$ =150° C.

D. The R_{0JA} is the sum of the thermal impedance from junction to case R_{0JC} and case to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300µs pulses, duty cycle 0.5% max.

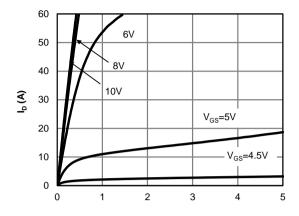
F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of T_{.I(MAX)}=150° C. The SOA curve provides a single pulse rating.

G. The maximum current rating is package limited.

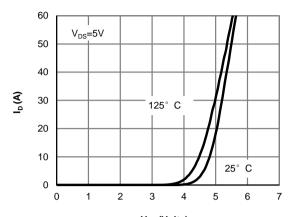
H. These tests are performed in a still air environment with $T_A=25^{\circ}$ C.



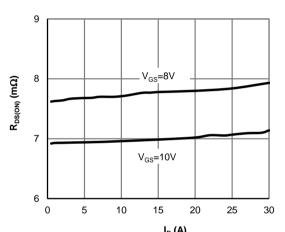
TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



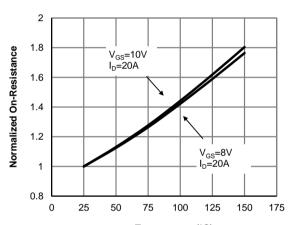
 $V_{\rm DS}$ (Volts) Figure 1: On-Region Characteristics (Note E)



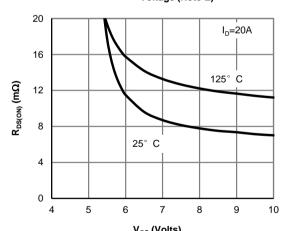
V_{GS} (Volts) Figure 2: Transfer Characteristics (Note E)



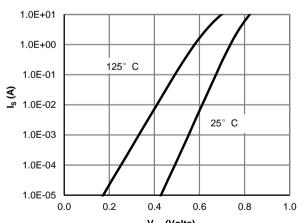
 ${\rm I_D}\left({\rm A} \right)$ Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)



Temperature (°C)
Figure 4: On-Resistance vs. Junction Temperature
(Note E)



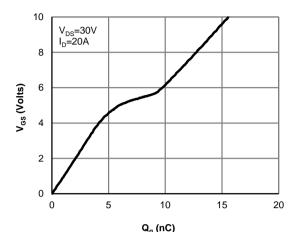
V_{GS} (Volts) Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)



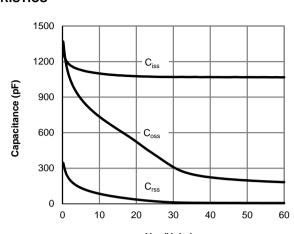
V_{SD} (Volts) Figure 6: Body-Diode Characteristics (Note E)



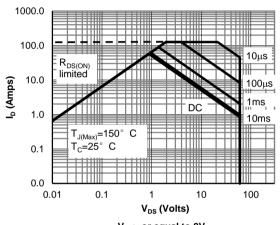
TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



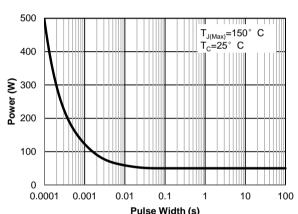
 ${\bf Q_g}$ (nC) Figure 7: Gate-Charge Characteristics



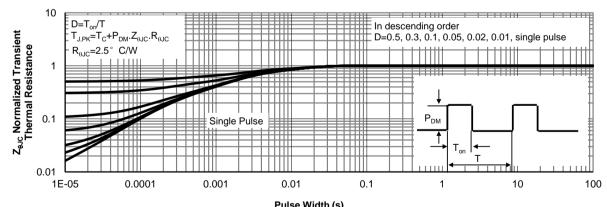
V_{DS} (Volts)
Figure 8: Capacitance Characteristics



V_{GS}> or equal to 8V Figure 9: Maximum Forward Biased Safe Operating Area (Note F)



Pulse Width (s)
Figure 10: Single Pulse Power Rating Junction-toCase (Note F)

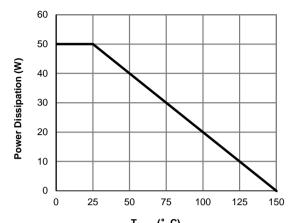


Pulse Width (s)
Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)

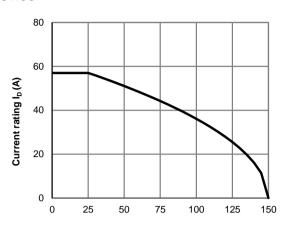
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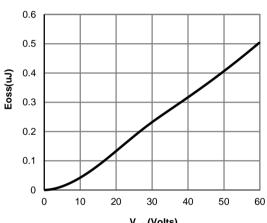
TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



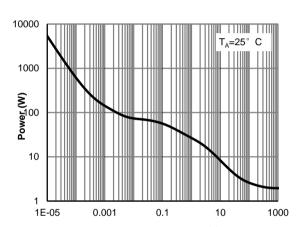
T_{CASE} (° C)
Figure 12: Power De-rating (Note F)



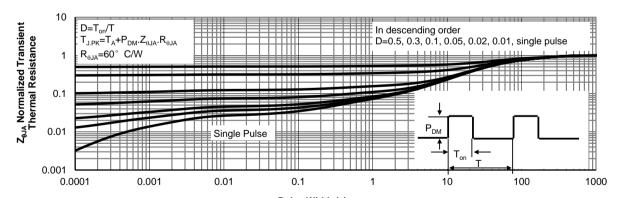
T_{CASE} (° C)
Figure 13: Current De-rating (Note F)



V_{DS} (Volts) Figure 14: Coss stored Energy



Pulse Width (s)
Figure 15: Single Pulse Power Rating Junctionto-Ambient (Note H)



Pulse Width (s)
Figure 16: Normalized Maximum Transient Thermal Impedance (Note H)

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Figure A: Gate Charge Test Circuit & Waveforms

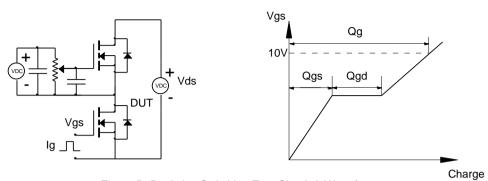


Figure B: Resistive Switching Test Circuit & Waveforms

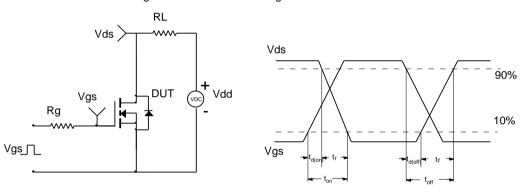


Figure C: Unclamped Inductive Switching (UIS) Test Circuit & Waveforms

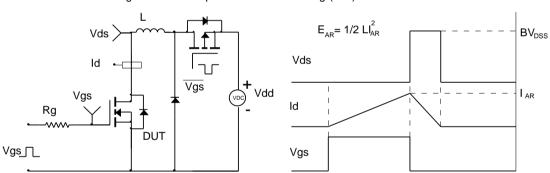
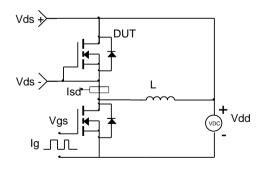
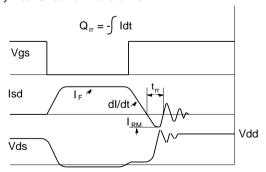


Figure D: Diode Recovery Test Circuit & Waveforms





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